

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/657,097	TANAKA, HIDEO	
Examiner Allen H. Nguyen		Art Unit 2625		Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,952,279	10-2005	Iida, Junichi	358/1.15
*	B US-6,825,955	11-2004	Shibata, Hiroshi	358/402
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

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N					
O					
P					
Q					
R					
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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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